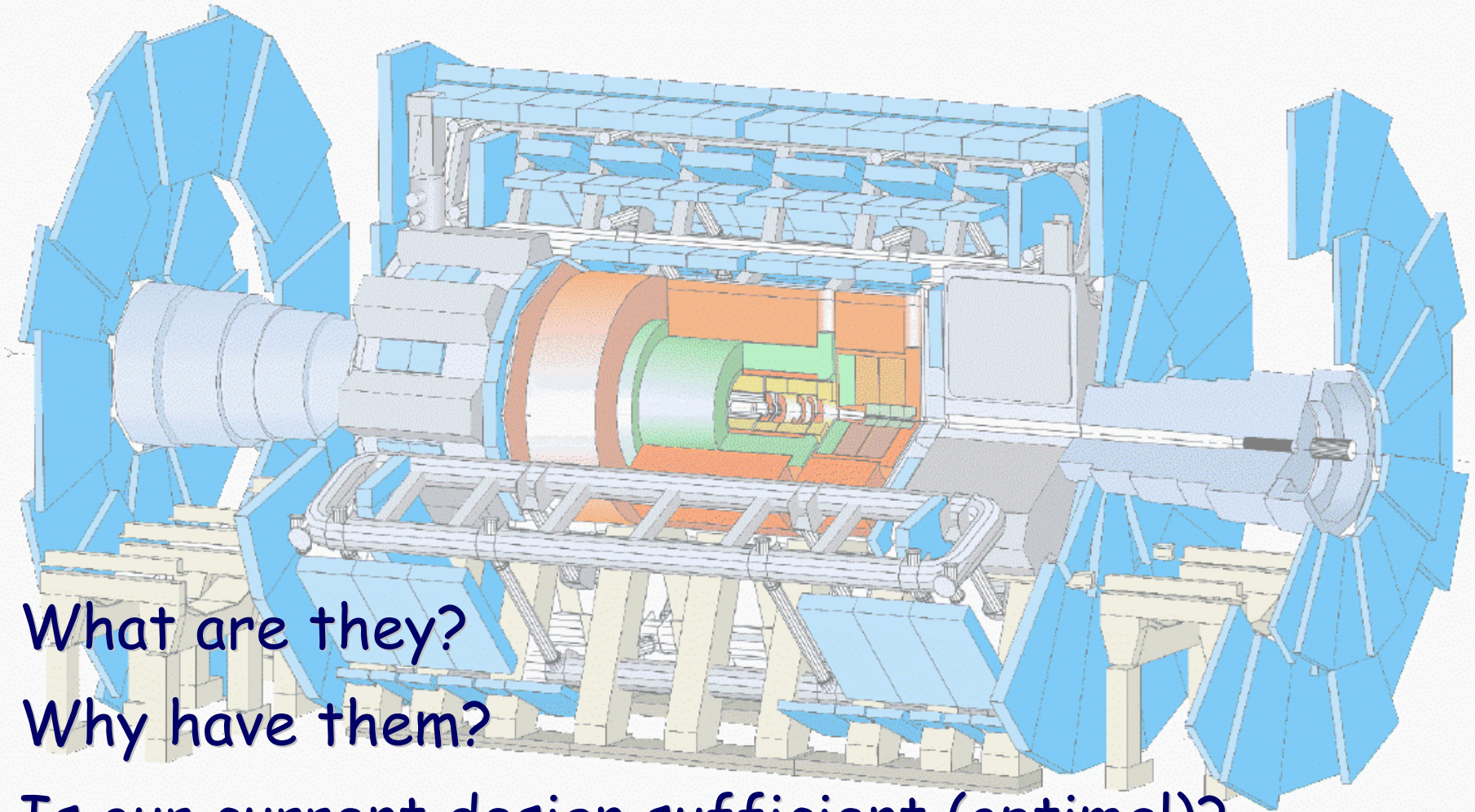


Secondary RoIs



What are they?

Why have them?

Is our current design sufficient (optimal)?



What is a "secondary RoI"?

Any RoI not involved in trigger decision

- 2E15I → **both** e/ γ RoIs "primary"
- 1MU6 + 1E15I → e/ γ RoI would be "secondary"

An RoI may be **intrinsically** secondary:

- Low- E_T object (probably unisolated)
- **Not used anywhere** in CTP trigger menu
- Used purely to guide **additional** selection in Level-2
 - use secondary e/ γ or jet RoI to guide LVL2 B triggers
 - use secondary e/ γ to ensure full readout of $H \rightarrow 4e$ at high lumi (where may prescale $Z \rightarrow ee$)



Implementation

Nothing Special

- Just set desired thresholds
- Will send multiplicity to CTP (*which will ignore it*)
- *Our* electronics makes *no distinction* between "primary" and "secondary" selections

Is there a problem?

- Uses *1/8* of our thresholds & Calo → CTP bandwidth
- Not a problem *provided* have spare capacity
- This was *included* in estimates of required no. thresholds
 - *only* an issue if we've underestimated requirements



Could Requirements be Underestimated?

Current design

- 8-16 e/γ + 0-8 τ/h classifications ($E_T + \text{isol}^n$)

Why so many?

- May need > 1 classification for single trigger menu item
 - isolation should be loosened for higher E_T objects
 - conversely, 1 classification may have > 1 use in trigger menu

But even so?

- Hard to imagine need > 16 e/γ classifications
 - could add more by restricting multiplicity, FPGA capacity permitting
 - pressure could arise if t trigger more important than expect

What might demands be?



e/γ

- Inclusive
 - 2-3 classifications
- Pair
 - 2 classifications
- Multielectron
 - 1 classification?
- Secondary RoI
 - 1 classification
- $e+E_T^{\text{miss}}$
 - 1 classification
- $e+\mu$, $e+\tau$, $e+n\text{Jet}$
 - ≤ 1 each
- Even if all needed, can **reuse** some classifications for **> 1 purpose**

τ/h

- Inclusive
 - 2 classifications
- Pair
 - 1-2 classifications
- Secondary RoI
 - 1 classification
- Calibration (prescaled)
 - 1 classification
- $\tau + E_T^{\text{miss}}$
 - 1 classification
- $\tau+\mu$, $\tau+e$, $\tau+n\text{Jet}$
 - ≤ 1 each



Is there an alternative?

Yes (in principle)

- add **extra** e/γ & τ/h thresholds
 - cluster E_T only, no isolation
- **do not** output CTP "hits" for these
 - those 48 (16×3) bits are a finite resource
- these additional thresholds **only** generate RoIs
 - RoI with **no threshold bits set** could indicate secondary (but could not distinguish e/g and t/h)

Is it possible?

- Would require "only" software & firmware changes 😊



A Radical Extension (just a bit of fun!)

Classify objects by **function**, not $E_T + \text{isol}^n$

- e.g. output 1 hit type for "inclusive e/γ ", rather than 2-3
 - same number of hit classifications would go further

How could this work?

- within FPGA, encode RoI E_T & isolation separately
 - E_T is natural, though no exact hierarchy for isolation
- input $E_T + \text{isol}^n$ codes to small LUT
 - output all functional classifications matched
- gain more with > 16 E_T thresholds (need fewer isolation)
 - but some gain just from mixing & matching E_T & isolation

Drawbacks?

- might need bigger FPGA
- would add a little latency

Leave this for the upgrade 😊



Summary

The issue is “necessarily secondary” RoIs

- some RoIs types may be **primary or secondary** in different events

Our current design can accommodate these

- by treating them as any other selections

There is some inefficiency

- “wastes” 6/48 of the bits we send to the CTP

There is an alternative

- which we can use **if** we need it
- hard to assess need in advance (but we don't currently believe there is a problem)